



## LC<sup>2</sup>MOS Quad SPST Switches

### ADG441/ADG442/ADG444

#### FEATURES

**44 V Supply Maximum Ratings**

**V<sub>SS</sub> to V<sub>DD</sub> Analog Signal Range**

**Low On Resistance (< 70  $\Omega$ )**

**Low  $\Delta R_{ON}$  (9  $\Omega$  max)**

**Low  $R_{ON}$  Match (3  $\Omega$  max)**

**Low Power Dissipation**

**Fast Switching Times**

**$t_{ON}$  < 110 ns**

**$t_{OFF}$  < 60 ns**

**Low Leakage Currents (3 nA max)**

**Low Charge Injection (6 pC max)**

**Break-Before-Make Switching Action**

**Latch-Up Proof**

**Plug-In Upgrade for**

**DG201A/ADG201A, DG202A/ADG202A,**

**DG211/ADG211A**

**Plug in Replacement for DG441/DG442/DG444**

#### APPLICATIONS

**Audio and Video Switching**

**Automatic Test Equipment**

**Precision Data Acquisition**

**Battery Powered Systems**

**Sample Hold Systems**

**Communication Systems**

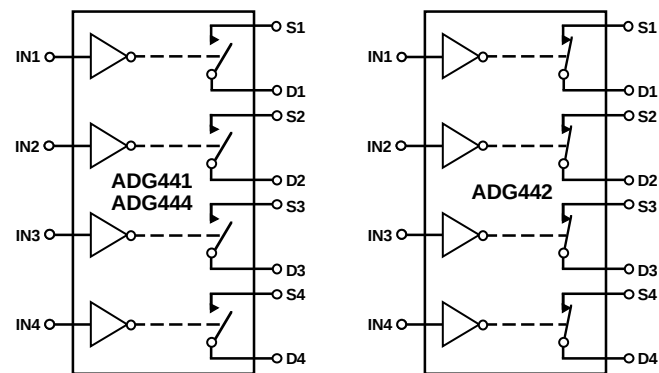
#### GENERAL DESCRIPTION

The ADG441, ADG442 and ADG444 are monolithic CMOS devices comprising four independently selectable switches. They are designed on an enhanced LC<sup>2</sup>MOS process that provides low power dissipation yet gives high switching speed and low on resistance.

The on resistance profile is very flat over the full analog input range ensuring good linearity and low distortion when switching audio signals. High switching speed also makes the parts suitable for video signal switching. CMOS construction ensures ultralow power dissipation making the parts ideally suited for portable and battery powered instruments.

The ADG441, ADG442 and ADG444 contain four independent SPST switches. Each switch of the ADG441 and ADG444 turns on when a logic low is applied to the appropriate control input. The ADG442 switches are turned on with a logic high on the appropriate control input. The ADG441 and ADG444 switches differ in that the ADG444 requires a 5 V logic power supply which is applied to the V<sub>L</sub> pin. The ADG441 and ADG442 do not have a V<sub>L</sub> pin, the logic power supply being generated internally by an on-chip voltage generator.

#### FUNCTIONAL BLOCK DIAGRAMS



SWITCHES SHOWN FOR A LOGIC "1" INPUT

Each switch conducts equally well in both directions when ON and has an input signal range that extends to the power supplies. In the OFF condition, signal levels up to the supplies are blocked. All switches exhibit break-before-make switching action for use in multiplexer applications. Inherent in the design is low charge injection for minimum transients when switching the digital inputs.

#### PRODUCT HIGHLIGHTS

- Extended Signal Range**  
The ADG441/ADG442/ADG444 are fabricated on an enhanced LC<sup>2</sup>MOS, trench-isolated process, giving an increased signal range that extends to the supply rails.
- Low Power Dissipation**
- Low  $R_{ON}$**
- Trench Isolation Guards Against Latch Up**  
A dielectric trench separates the P and N channel transistors thereby preventing latch up even under severe overvoltage conditions.
- Break-Before-Make Switching**  
This prevents channel shorting when the switches are configured as a multiplexer.
- Single Supply Operation**  
For applications where the analog signal is unipolar, the ADG441/ADG442/ADG444 can be operated from a single rail power supply. The parts are fully specified with a single +12 V power supply.

#### REV. 0

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# ADG441/ADG442/ADG444—SPECIFICATIONS<sup>1</sup>

**Dual Supply** ( $V_{DD} = +15\text{ V} \pm 10\%$ ,  $V_{SS} = -15\text{ V} \pm 10\%$ ,  $V_L = +5\text{ V} \pm 10\%$  (ADG444),  $GND = 0\text{ V}$ , unless otherwise noted)

|                                                         | B Version |                                    | T Version |                                    |        |                                                                    |
|---------------------------------------------------------|-----------|------------------------------------|-----------|------------------------------------|--------|--------------------------------------------------------------------|
| Parameter                                               | +25°C     | −40°C to +85°C                     | +25°C     | −55°C to +125°C                    | Units  | Test Conditions/Comments                                           |
| ANALOG SWITCH                                           |           |                                    |           |                                    |        |                                                                    |
| Analog Signal Range                                     |           | V <sub>SS</sub> to V <sub>DD</sub> |           | V <sub>SS</sub> to V <sub>DD</sub> | V      |                                                                    |
| R <sub>ON</sub>                                         | 40        |                                    | 40        |                                    | Ω typ  | V <sub>D</sub> = ±8.5 V, I <sub>S</sub> = −10 mA                   |
|                                                         | 70        | 85                                 | 70        | 85                                 | Ω max  | V <sub>DD</sub> = +13.5 V, V <sub>SS</sub> = −13.5 V               |
| ΔR <sub>ON</sub>                                        |           | 4                                  |           | 4                                  | Ω typ  | −8.5 V ≤ V <sub>D</sub> ≤ +8.5 V                                   |
|                                                         |           | 9                                  |           | 9                                  | Ω max  |                                                                    |
| R <sub>ON</sub> Match                                   |           | 1                                  |           | 1                                  | Ω typ  | V <sub>D</sub> = 0 V, I <sub>S</sub> = −10 mA                      |
|                                                         |           | 3                                  |           | 3                                  | Ω max  |                                                                    |
| LEAKAGE CURRENTS                                        |           |                                    |           |                                    |        |                                                                    |
| Source OFF Leakage I <sub>S</sub> (OFF)                 | ±0.01     |                                    | ±0.01     |                                    | nA typ | V <sub>DD</sub> = +16.5 V, V <sub>SS</sub> = −16.5 V               |
|                                                         | ±0.5      | ±3                                 | ±0.5      | ±20                                | nA max | V <sub>D</sub> = ±15.5 V, V <sub>S</sub> = ∓15.5 V;                |
| Drain OFF Leakage I <sub>D</sub> (OFF)                  | ±0.01     |                                    | ±0.01     |                                    | nA typ | Test Circuit 2                                                     |
|                                                         | ±0.5      | ±3                                 | ±0.5      | ±20                                | nA max | V <sub>D</sub> = ±15.5 V, V <sub>S</sub> = ∓15.5 V;                |
| Channel ON Leakage I <sub>D</sub> , I <sub>S</sub> (ON) | ±0.08     |                                    | ±0.08     |                                    | nA typ | Test Circuit 2                                                     |
|                                                         | ±0.5      | ±3                                 | ±0.5      | ±40                                | nA max | V <sub>S</sub> = V <sub>D</sub> = ±15.5 V;                         |
|                                                         |           |                                    |           |                                    |        | Test Circuit 3                                                     |
| DIGITAL INPUTS                                          |           |                                    |           |                                    |        |                                                                    |
| Input High Voltage, V <sub>INH</sub>                    |           | 2.4                                |           | 2.4                                | V min  |                                                                    |
| Input Low Voltage, V <sub>INL</sub>                     |           | 0.8                                |           | 0.8                                | V max  |                                                                    |
| Input Current                                           |           |                                    |           |                                    |        |                                                                    |
| I <sub>INL</sub> or I <sub>INH</sub>                    |           | ±0.00001                           |           | ±0.00001                           | μA typ | V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>             |
|                                                         |           | ±0.5                               |           | ±0.5                               | μA max |                                                                    |
| DYNAMIC CHARACTERISTICS <sup>2</sup>                    |           |                                    |           |                                    |        |                                                                    |
| t <sub>ON</sub>                                         | 85        |                                    | 85        |                                    | ns typ | R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 35 pF;                     |
|                                                         | 110       | 170                                | 110       | 170                                | ns max | V <sub>S</sub> = ±10 V; Test Circuit 4                             |
| t <sub>OFF</sub>                                        | 45        |                                    | 45        |                                    | ns typ | R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 35 pF;                     |
|                                                         | 60        | 80                                 | 60        | 80                                 | ns max | V <sub>S</sub> = ±10 V; Test Circuit 4                             |
| t <sub>OPEN</sub>                                       | 30        |                                    | 30        |                                    | ns typ | R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 35 pF;                     |
| Charge Injection                                        | 1         |                                    | 1         |                                    | pC typ | V <sub>S</sub> = 0 V, R <sub>S</sub> = 0 Ω, C <sub>L</sub> = 1 nF; |
|                                                         | 6         |                                    | 6         |                                    | pC max | V <sub>DD</sub> = +15 V, V <sub>SS</sub> = −15 V;                  |
|                                                         |           |                                    |           |                                    |        | Test Circuit 5                                                     |
| OFF Isolation                                           | 60        |                                    | 60        |                                    | dB typ | R <sub>L</sub> = 50 Ω, C <sub>L</sub> = 5 pF;                      |
|                                                         |           |                                    |           |                                    |        | f = 1 MHz; Test Circuit 6                                          |
| Channel-to-Channel Crosstalk                            | 100       |                                    | 100       |                                    | dB typ | R <sub>L</sub> = 50 Ω, C <sub>L</sub> = 5 pF;                      |
|                                                         |           |                                    |           |                                    |        | f = 1 MHz; Test Circuit 7                                          |
| C <sub>S</sub> (OFF)                                    | 4         |                                    | 4         |                                    | pF typ | f = 1 MHz                                                          |
| C <sub>D</sub> (OFF)                                    | 4         |                                    | 4         |                                    | pF typ | f = 1 MHz                                                          |
| C <sub>D</sub> , C <sub>S</sub> (ON)                    | 16        |                                    | 16        |                                    | pF typ | f = 1 MHz                                                          |
| POWER REQUIREMENTS                                      |           |                                    |           |                                    |        |                                                                    |
| I <sub>DD</sub>                                         |           |                                    |           |                                    |        | V <sub>DD</sub> = +16.5 V, V <sub>SS</sub> = −16.5 V               |
| ADG441/ADG442                                           |           | 80                                 |           | 80                                 | μA max | Digital Inputs = 0 V or 5 V                                        |
| ADG444                                                  | 0.001     |                                    | 0.001     |                                    | μA typ |                                                                    |
|                                                         | 1         | 2.5                                | 1         | 2.5                                | μA max |                                                                    |
| I <sub>SS</sub>                                         | 0.0001    |                                    | 0.0001    |                                    | μA typ |                                                                    |
|                                                         | 1         | 2.5                                | 1         | 2.5                                | μA max |                                                                    |
| I <sub>L</sub> (ADG444 Only)                            | 0.001     |                                    | 0.001     |                                    | μA typ | V <sub>L</sub> = +5.5 V                                            |
|                                                         | 1         | 2.5                                | 1         | 2.5                                | μA max |                                                                    |

## NOTES

<sup>1</sup>Temperature ranges are as follows: B Versions: −40°C to +85°C; T Versions: −55°C to +125°C.

<sup>2</sup>Guaranteed by design, not subject to production test.

Specifications subject to change without notice.

# ADG441/ADG442/ADG444

**Single Supply** ( $V_{DD} = +12\text{ V} \pm 10\%$ ,  $V_{SS} = 0\text{ V}$ ,  $V_L = +5\text{ V} \pm 10\%$  (ADG444),  $GND = 0\text{ V}$ , unless otherwise noted)

|                                                         | B Version |                      | T Version |                      |        |                                                                    |
|---------------------------------------------------------|-----------|----------------------|-----------|----------------------|--------|--------------------------------------------------------------------|
| Parameter                                               | +25°C     | −40°C to +85°C       | +25°C     | −55°C to +125°C      | Units  | Test Conditions/Comments                                           |
| ANALOG SWITCH                                           |           |                      |           |                      |        |                                                                    |
| Analog Signal Range                                     |           | 0 to V <sub>DD</sub> |           | 0 to V <sub>DD</sub> | V      |                                                                    |
| R <sub>ON</sub>                                         | 70        |                      | 70        |                      | Ω typ  | V <sub>D</sub> = +3 V, +8 V, I <sub>S</sub> = −10 mA;              |
|                                                         | 110       | 130                  | 110       | 130                  | Ω max  | V <sub>DD</sub> = +10.8 V                                          |
| ΔR <sub>ON</sub>                                        |           | 4                    |           | 4                    | Ω typ  | +3 V ≤ V <sub>D</sub> ≤ +8 V                                       |
|                                                         |           | 9                    |           | 9                    | Ω max  |                                                                    |
| R <sub>ON</sub> Match                                   |           | 1                    |           | 1                    | Ω typ  | V <sub>D</sub> = 6 V, I <sub>S</sub> = −10 mA                      |
|                                                         |           | 3                    |           | 3                    | Ω max  |                                                                    |
| LEAKAGE CURRENT                                         |           |                      |           |                      |        |                                                                    |
| Source OFF Leakage I <sub>S</sub> (OFF)                 | ±0.01     |                      | ±0.01     |                      | nA typ | V <sub>DD</sub> = +13.2 V                                          |
|                                                         | ±0.5      | ±3                   | ±0.5      | ±20                  | nA max | V <sub>D</sub> = 12.2 V/1 V, V <sub>S</sub> = 1 V/12.2 V;          |
| Drain OFF Leakage I <sub>D</sub> (OFF)                  | ±0.01     |                      | ±0.01     |                      | nA typ | Test Circuit 2                                                     |
|                                                         | ±0.5      | ±3                   | ±0.5      | ±20                  | nA max | V <sub>D</sub> = 12.2 V/1 V, V <sub>S</sub> = 1 V/12.2 V;          |
| Channel ON Leakage I <sub>D</sub> , I <sub>S</sub> (ON) | ±0.08     |                      | ±0.08     |                      | nA typ | Test Circuit 2                                                     |
|                                                         | ±0.5      | ±3                   | ±0.5      | ±40                  | nA max | V <sub>S</sub> = V <sub>D</sub> = 12.2 V/1 V;                      |
|                                                         |           |                      |           |                      |        | Test Circuit 3                                                     |
| DIGITAL INPUTS                                          |           |                      |           |                      |        |                                                                    |
| Input High Voltage, V <sub>INH</sub>                    |           | 2.4                  |           | 2.4                  | V min  |                                                                    |
| Input Low Voltage, V <sub>INL</sub>                     |           | 0.8                  |           | 0.8                  | V max  |                                                                    |
| Input Current                                           |           |                      |           |                      |        |                                                                    |
| I <sub>INL</sub> or I <sub>INH</sub>                    |           | ±0.00001             |           | ±0.00001             | μA typ | V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>             |
|                                                         |           | ±0.5                 |           | ±0.5                 | μA max |                                                                    |
| DYNAMIC CHARACTERISTICS <sup>2</sup>                    |           |                      |           |                      |        |                                                                    |
| t <sub>ON</sub>                                         | 105       |                      | 105       |                      | ns typ | R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 35 pF;                     |
|                                                         | 150       | 220                  | 150       | 220                  | ns max | V <sub>S</sub> = +8 V; Test Circuit 4                              |
| t <sub>OFF</sub>                                        | 40        |                      | 40        |                      | ns typ | R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 35 pF;                     |
|                                                         | 60        | 100                  | 60        | 100                  | ns max | V <sub>S</sub> = +8 V; Test Circuit 4                              |
| t <sub>OPEN</sub>                                       | 50        |                      | 50        |                      | ns typ | R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 35 pF;                     |
| Charge Injection                                        | 2         |                      | 2         |                      | pC typ | V <sub>S</sub> = 6 V, R <sub>S</sub> = 0 Ω, C <sub>L</sub> = 1 nF; |
|                                                         | 6         |                      | 6         |                      | pC max | V <sub>DD</sub> = +12 V, V <sub>SS</sub> = 0 V;                    |
|                                                         |           |                      |           |                      |        | Test Circuit 5                                                     |
| OFF Isolation                                           | 60        |                      | 60        |                      | dB typ | R <sub>L</sub> = 50 Ω, C <sub>L</sub> = 5 pF, f = 1 MHz;           |
|                                                         |           |                      |           |                      |        | Test Circuit 6                                                     |
| Channel-to-Channel Crosstalk                            | 100       |                      | 100       |                      | dB typ | R <sub>L</sub> = 50 Ω, C <sub>L</sub> = 5 pF, f = 1 MHz;           |
|                                                         |           |                      |           |                      |        | Test Circuit 7                                                     |
| C <sub>S</sub> (OFF)                                    | 7         |                      | 7         |                      | pF typ | f = 1 MHz                                                          |
| C <sub>D</sub> (OFF)                                    | 10        |                      | 10        |                      | pF typ | f = 1 MHz                                                          |
| C <sub>D</sub> , C <sub>S</sub> (ON)                    | 16        |                      | 16        |                      | pF typ | f = 1 MHz                                                          |
| POWER REQUIREMENTS                                      |           |                      |           |                      |        |                                                                    |
| I <sub>DD</sub>                                         |           |                      |           |                      |        | V <sub>DD</sub> = +13.2 V                                          |
| ADG441/ADG442                                           |           | 80                   |           | 80                   | μA max | Digital Inputs = 0 V or 5 V                                        |
| ADG444                                                  | 0.001     |                      | 0.001     |                      | μA typ |                                                                    |
|                                                         | 1         | 2.5                  | 1         | 2.5                  | μA max |                                                                    |
| I <sub>L</sub> (ADG444 Only)                            | 0.001     |                      | 0.001     |                      | μA typ | V <sub>L</sub> = +5.5 V                                            |
|                                                         | 1         | 2.5                  | 1         | 2.5                  | μA max |                                                                    |

## NOTES

<sup>1</sup>Temperature ranges are as follows: B Versions: –40°C to +85°C; T Versions: –55°C to +125°C.

<sup>2</sup>Guaranteed by design, not subject to production test.

Specifications subject to change without notice.

## ORDERING GUIDE

**Table I. Truth Table**

| ADG441/ADG444<br>IN | ADG442<br>IN | Switch<br>Condition |
|---------------------|--------------|---------------------|
| 0                   | 1            | ON                  |
| 1                   | 0            | OFF                 |

| Model <sup>1</sup> | Temperature Range | Package Option <sup>2</sup> |
|--------------------|-------------------|-----------------------------|
| ADG441BN           | –40°C to +85°C    | N-16                        |
| ADG441BR           | –40°C to +85°C    | R-16A                       |
| ADG441TQ           | –55°C to +125°C   | Q-16                        |
| ADG442BN           | –40°C to +85°C    | N-16                        |
| ADG442BR           | –40°C to +85°C    | R-16A                       |
| ADG444BN           | –40°C to +85°C    | N-16                        |
| ADG444BR           | –40°C to +85°C    | R-16A                       |

## NOTES

<sup>1</sup>To order MIL-STD-883, Class B processed parts, add /883B to T grade part numbers.

<sup>2</sup>N = Plastic DIP, R = 0.15" Small Outline IC (SOIC), Q = Cerdip.

# ADG441/ADG442/ADG444

## ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

(T<sub>A</sub> = +25°C unless otherwise noted)

|                                                              |                                                                                    |
|--------------------------------------------------------------|------------------------------------------------------------------------------------|
| V <sub>DD</sub> to V <sub>SS</sub>                           | +44 V                                                                              |
| V <sub>DD</sub> to GND                                       | −0.3 V to +25 V                                                                    |
| V <sub>SS</sub> to GND                                       | +0.3 V to −25 V                                                                    |
| V <sub>L</sub> to GND                                        | −0.3 V to V <sub>DD</sub> + 0.3 V                                                  |
| Analog, Digital Inputs <sup>2</sup>                          | V <sub>SS</sub> − 2 V to V <sub>DD</sub> + 2 V<br>or 30 mA, Whichever Occurs First |
| Continuous Current, S or D                                   | 30 mA                                                                              |
| Peak Current, S or D<br>(Pulsed at 1 ms, 10% Duty Cycle Max) | 100 mA                                                                             |
| Operating Temperature Range                                  |                                                                                    |
| Industrial (B Version)                                       | −40°C to +85°C                                                                     |
| Extended (T Version)                                         | −55°C to +125°C                                                                    |
| Storage Temperature Range                                    | −65°C to +150°C                                                                    |
| Junction Temperature                                         | +150°C                                                                             |
| Cerdip Package, Power Dissipation                            | 900 mW                                                                             |
| θ <sub>JA</sub> , Thermal Impedance                          | 76°C/W                                                                             |
| Lead Temperature, Soldering (10 sec)                         | +300°C                                                                             |
| Plastic Package, Power Dissipation                           | 470 mW                                                                             |
| θ <sub>JA</sub> , Thermal Impedance                          | 177°C/W                                                                            |
| Lead Temperature, Soldering (10 sec)                         | +260°C                                                                             |
| SOIC Package, Power Dissipation                              | 600 mW                                                                             |
| θ <sub>JA</sub> , Thermal Impedance                          | 77°C/W                                                                             |
| Lead Temperature, Soldering                                  |                                                                                    |
| Vapor Phase (60 sec)                                         | +215°C                                                                             |
| Infrared (15 sec)                                            | +220°C                                                                             |

## NOTES

<sup>1</sup>Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Only one absolute maximum rating may be applied at any one time.

<sup>2</sup>Overvoltages at IN, S or D will be clamped by internal diodes. Current should be limited to the maximum ratings given.

## TERMINOLOGY

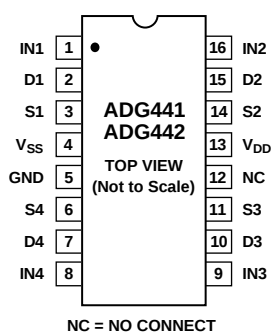
|                                      |                                                                                                                         |
|--------------------------------------|-------------------------------------------------------------------------------------------------------------------------|
| V <sub>DD</sub>                      | Most Positive Power Supply Potential.                                                                                   |
| V <sub>SS</sub>                      | Most Negative Power Supply Potential in dual supplies. In single supply applications, it may be connected to ground.    |
| V <sub>L</sub>                       | Logic Power Supply (+5 V).                                                                                              |
| GND                                  | Ground (0 V) Reference.                                                                                                 |
| S                                    | Source Terminal. May be an input or output.                                                                             |
| D                                    | Drain Terminal. May be an input or output.                                                                              |
| IN                                   | Logic Control Input.                                                                                                    |
| R <sub>ON</sub>                      | Ohmic resistance between D and S.                                                                                       |
| R <sub>ON</sub> Match                | Difference between the R <sub>ON</sub> of any two channels.                                                             |
| I <sub>S</sub> (OFF)                 | Source leakage current with the switch “OFF.”                                                                           |
| I <sub>D</sub> (OFF)                 | Drain leakage current with the switch “OFF.”                                                                            |
| I <sub>D</sub> , I <sub>S</sub> (ON) | Channel leakage current with the switch “ON.”                                                                           |
| V <sub>D</sub> (V <sub>S</sub> )     | Analog voltage on terminals D, S.                                                                                       |
| C <sub>S</sub> (OFF)                 | “OFF” Switch Source Capacitance.                                                                                        |
| C <sub>D</sub> (OFF)                 | “OFF” Switch Drain Capacitance.                                                                                         |
| C <sub>D</sub> , C <sub>S</sub> (ON) | “ON” Switch Capacitance.                                                                                                |
| t <sub>ON</sub>                      | Delay between applying the digital control input and the output switching on.                                           |
| t <sub>OFF</sub>                     | Delay between applying the digital control input and the output switching off.                                          |
| t <sub>OPEN</sub>                    | Break-Before-Make Delay when switches are configured as a multiplexer.                                                  |
| Crosstalk                            | A measure of unwanted signal which is coupled through from one channel to another as a result of parasitic capacitance. |
| Off Isolation                        | A measure of unwanted signal coupling through an “OFF” switch.                                                          |
| Charge Injection                     | A measure of the glitch impulse transferred from the digital input to the analog output during switching.               |

## CAUTION

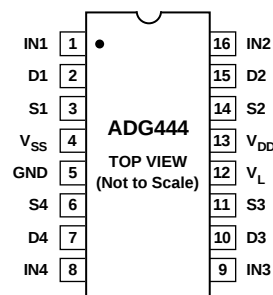
ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although these devices feature proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



ADG441/ADG442 PIN CONFIGURATION (DIP/SOIC)



ADG444 PIN CONFIGURATION (DIP/SOIC)



## TRENCH ISOLATION

In the ADG441, ADG442 and ADG444, an insulating oxide layer (trench) is placed between the NMOS and the PMOS transistors of each CMOS switch. Parasitic junctions, which occur between the transistors in junction isolated switches, are eliminated, the result being a completely latch-up proof switch.

In junction isolation, the N and P wells of the PMOS and NMOS transistors form a diode that is reverse-biased under normal operation. However, during overvoltage conditions, this diode becomes forward biased. A silicon-controlled rectifier (SCR) type circuit is formed by the two transistors causing a significant amplification of the current which, in turn, leads to latch up. With trench isolation, this diode is removed, the result being a latch-up proof switch.

Trench isolation also leads to lower leakage currents. The ADG441, ADG442 and ADG444 have a leakage current of 0.5 nA as compared with a leakage current of several nanoamperes in non-trench isolated switches. Leakage current is an important parameter in sample-and-hold circuits, this current being responsible for the discharge of the holding capacitor with time causing droop. The ADG441/ADG442/ADG444's low leakage current, along with its fast switching speeds, make it suitable for fast and accurate sample-and-hold circuits.

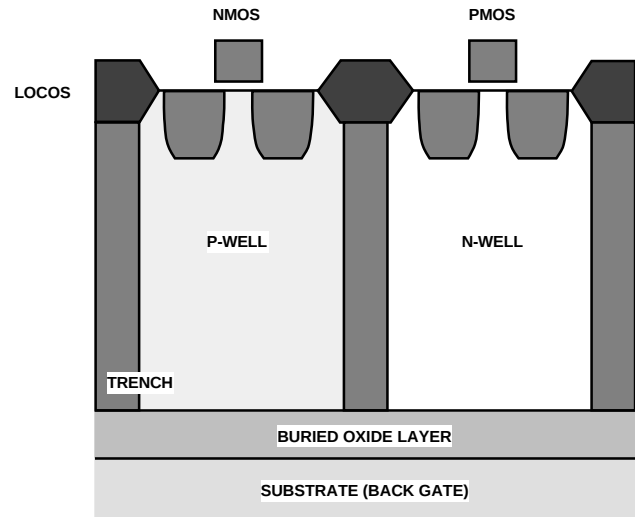


Figure 1. Trench Isolation

## Typical Performance Characteristics

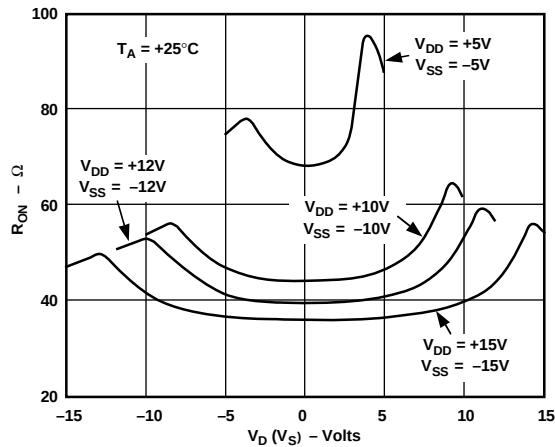


Figure 2.  $R_{ON}$  as a Function of  $V_D$  ( $V_S$ ): Dual Supply

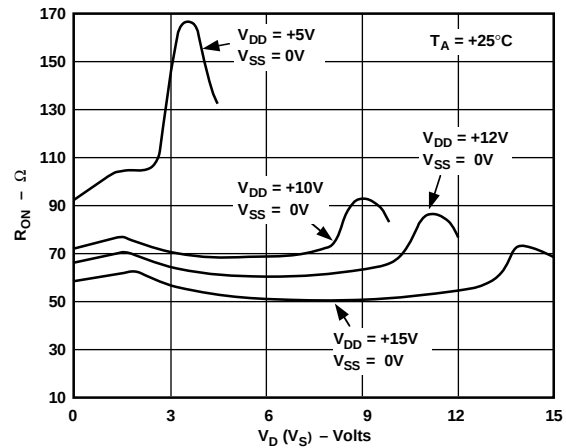


Figure 3.  $R_{ON}$  as a Function of  $V_D$  ( $V_S$ ): Single Supply

# ADG441/ADG442/ADG444

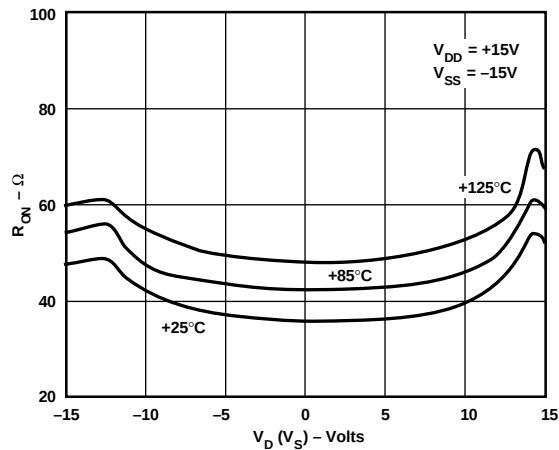


Figure 4.  $R_{ON}$  as a Function of  $V_D$  ( $V_S$ ) for Different Temperatures

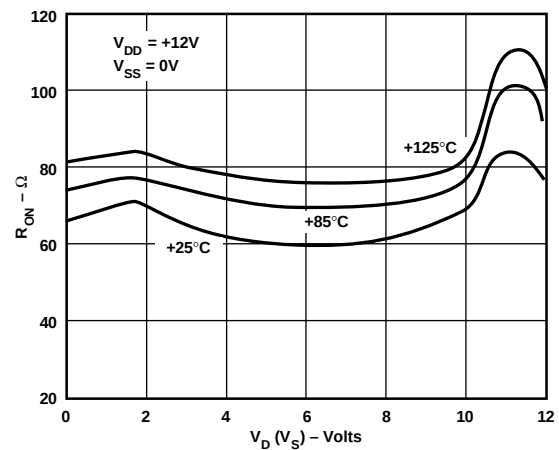


Figure 7.  $R_{ON}$  as a Function of  $V_D$  ( $V_S$ ) for Different Temperatures

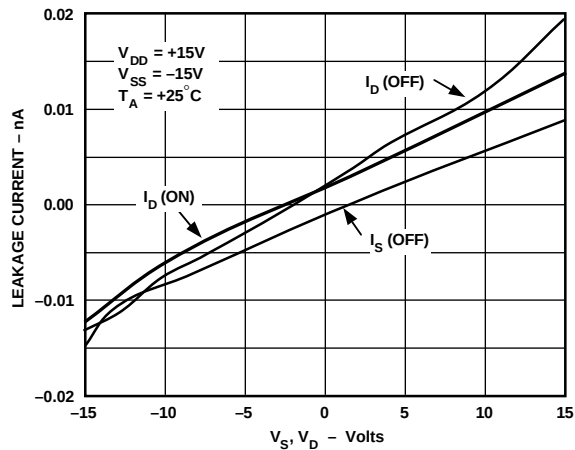


Figure 5. Leakage Currents as a Function of  $V_S$  ( $V_D$ )

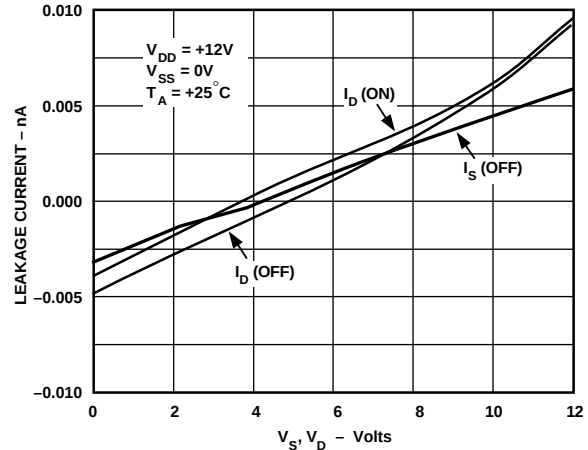


Figure 8. Leakage Currents as a Function of  $V_S$  ( $V_D$ )

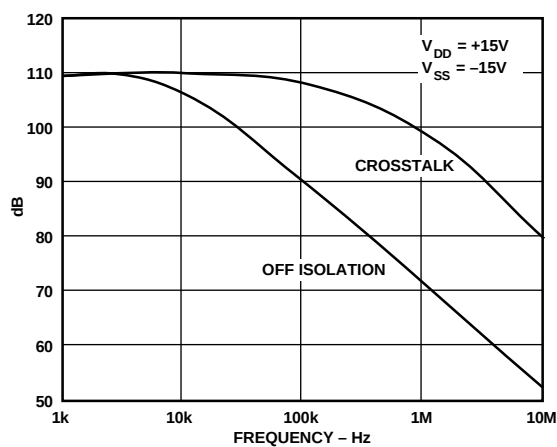


Figure 6. Crosstalk and Off Isolation vs. Frequency

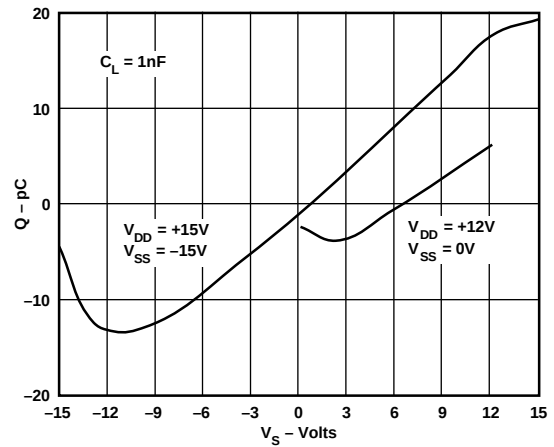


Figure 9. Charge Injection vs. Source Voltage

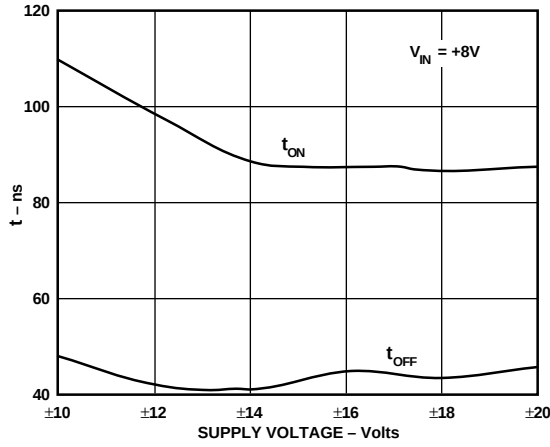


Figure 10. Switching Time vs. Bipolar Supply

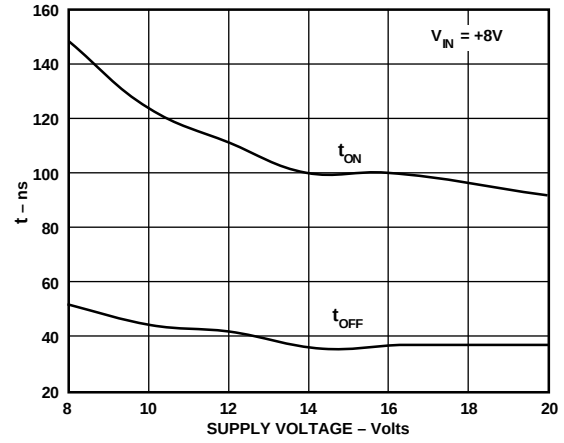
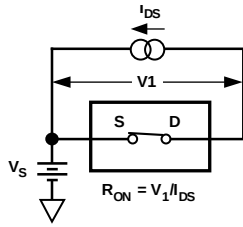
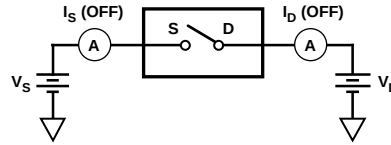


Figure 11. Switching Time vs. Single Supply

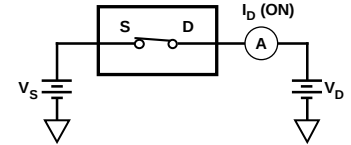
## Test Circuits



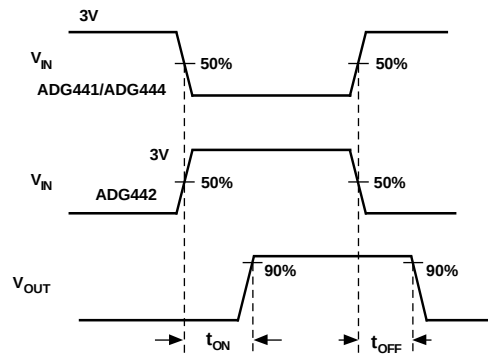
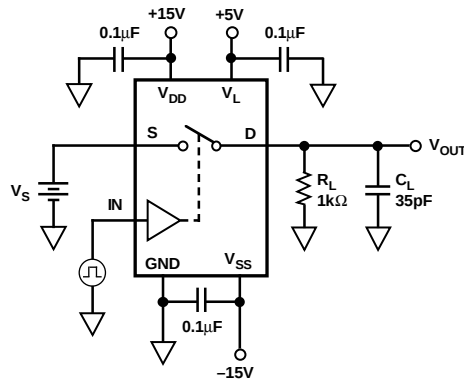
Test Circuit 1. On Resistance



Test Circuit 2. Off Leakage

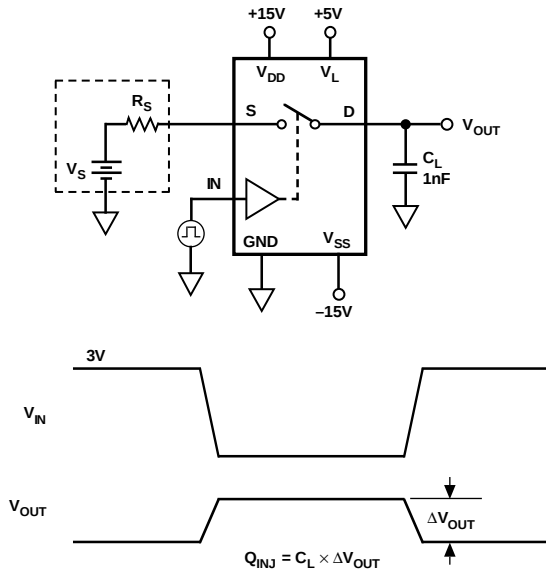


Test Circuit 3. On Leakage

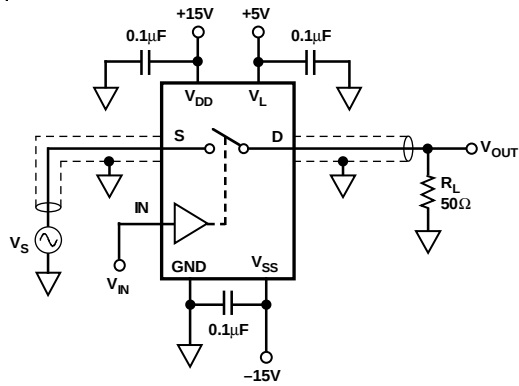


Test Circuit 4. Switching Times

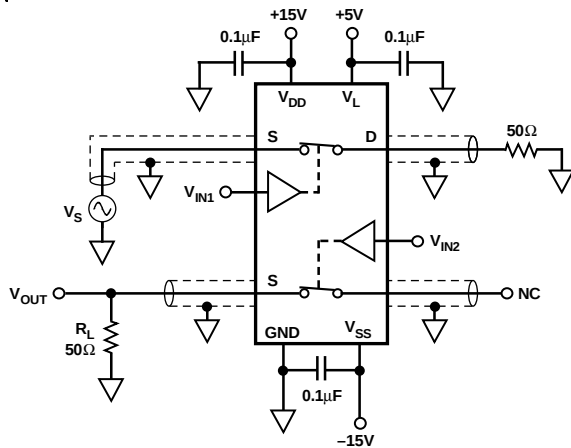
## ADG441/ADG442/ADG444



### Test Circuit 5. Charge Injection



### Test Circuit 6. Off Isolation



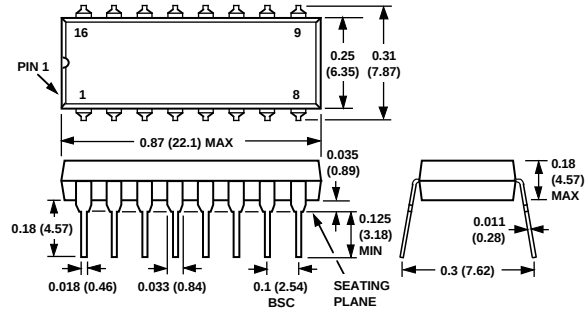
$$\text{CHANNEL-TO-CHANNEL CROSSTALK} = 20 \times \text{LOG} |V_S N_{\text{OUT}}|$$

### Test Circuit 7. Channel-to-Channel Crosstalk

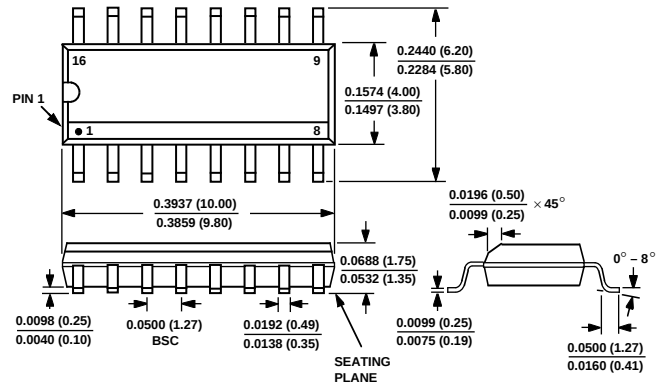
## OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

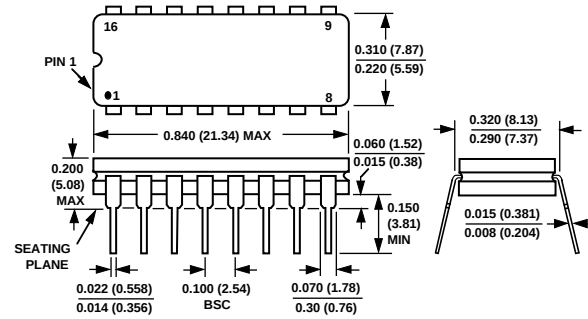
### Plastic DIP (N-16)



### Small Outline IC (R-16A)



**Cerdip (Q-16)**



# ADG441/ADG442/ADG444

## FOR CATALOG

### ORDERING GUIDE

| Model <sup>1</sup> | Temperature Range | Package Option <sup>2</sup> |
|--------------------|-------------------|-----------------------------|
| ADG441BN           | −40°C to +85°C    | N-16                        |
| ADG441BR           | −40°C to +85°C    | R-16A                       |
| ADG441TQ           | −55°C to +125°C   | Q-16                        |
| ADG442BN           | −40°C to +85°C    | N-16                        |
| ADG442BR           | −40°C to +85°C    | R-16A                       |
| ADG444BN           | −40°C to +85°C    | N-16                        |
| ADG444BR           | −40°C to +85°C    | R-16A                       |

#### NOTES

<sup>1</sup>To order MIL-STD-883, Class B processed parts, add /883B to T grade part numbers.

<sup>2</sup>N = Plastic DIP, R = 0.15" Small Outline IC (SOIC), Q = Cerdip. For outline information see Package Information section.